Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/248,111	NAKANO ET AL.	
Examiner	Art Unit	
SHAWN AN	2621	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	240.01	12/18/2008	SA
	240.02		SA
	240.23		SA
	240.24		SA
382	239		SA
	246		SA

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		